Application No. 10/674209
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Amendment
Attorney Docket No. O11.2B-11333-US01

## Amendments To The Claims:

 (Currently Amended) A polishing composition used in a polishing process for reducing haze level of wafer surface, comprising:

hydroxyethyl cellulose compounded in said composition in a quantity larger-than  $\underline{\text{of}}\ 0.01\%$  by weight and smaller than  $\underline{\text{to}}\ 3\%$  by weight and having an average molecular weight in the range of 300,000 to 3,000,000;

polyethylene oxide compounded in said composition in a quantity larger than 0.005% by weight and smaller than 0.5% by weight and having an average molecular weight in the range of 30,000 to 50,000,000;

an alkaline compound;

water; and

silicon dioxide.

- (Original) The polishing composition according to claim 1, wherein the total content of iron, nickel, copper, and calcium in the silicon dioxide, as measured in a 20 wt-% aqueous solution of said silicon dioxide, is 300 ppm or less.
- (Original) The polishing composition according to claim 1, wherein the content of hydroxyethyl cellulose in the polishing composition is 0.1 to 1% by weight.
- (Original) The polishing composition according to claim 1, wherein the content of silicon dioxide in the polishing composition is 3 to 20% by weight.
- (Original) The polishing composition according to claim 1, wherein the alkaline compound is ammonia.

Please cancel claims 6-13.